

1. Record Nr.	UNINA9910138783103321
Titolo	The IEEE International Symposium on Defect and Fault-Tolerance in VLSI Systems : proceedings : Chicago, Illinois, 7-9 October 2009 // edited by Dimitris Gizopoulos, Mohammad Tehranipoor, and Spyros Tragoudas ; sponsored by the IEEE Computer Society Technical Committee on Fault-Tolerant Computing, the IEEE Test Technology Technical Council
Pubbl/distr/stampa	New York : , : IEEE, , 2009
ISBN	1-5090-7533-X
Descrizione fisica	1 online resource (xxxi, 455 pages)
Soggetti	Fault-tolerant computing Integrated circuits - Very large scale integration - Design and construction
Lingua di pubblicazione	Inglese
Formato	Materiale a stampa
Livello bibliografico	Monografia
Note generali	Includes index.